High level illumination effect on MS'S solar cell characteristics with a new material Ga₂Se₃, as an intermediate layer

M. BHATNAGAR, P. K. BHATNAGAR

Department of Electronic Science, University of Delhi, South Campus, New Delhi-110021, India

Compound semiconductor heterostructure (Al–Ga₂Se₃–nSi) uses a new material for photovoltaic applications. This Metal-Semiconductor-Semiconductor (MS'S) structure with Ga₂Se₃ as an intermediate layer has been proposed as a better alternative to conventional Metal-Insulator-Semiconductor (MIS) solar cells for normal illumination. It is shown here that in the whole range – starting from lower intensity, i.e. at a concentration ratio, $C_r \sim 1$, to very high illumination level, $C_r \sim 2000$, the proposed new structure gives better results than corresponding MIS solar cells. © 1998 Chapman & Hall

1. Introduction

It has been shown [1, 2] that a wide band gap semiconductor layer with a thickness less than the Debye screening length behaves like an insulator and such a layer could be used in place of oxide on silicon. Ga_2Se_3 (band gap $\approx 1.9 \text{ eV}$) has a very good lattice match with silicon and has been shown experimentally to be equivalent to a metal-oxide semiconductor (MOS) in structure with reduced interface states $(D_{\rm s} = 10^{13} \text{ m}^2)$. Recently [3], current-voltage (I-V)characteristics, power fill factor and other parameters have been calculated for a metal– Ga_2Se_3-nSi system under normal illumination and have been found to be better than the typical MOS solar cell [4] because of the improved interface having a thickness of ~ 3.5 nm. Further, such a layer has been fabricated and reported [5, 6] for some other application. The effect of high temperature on these cells has already been considered elsewhere [7]. In the present work we show the effect of high intensity on these MS'S solar cells.

The solar-cell structure (metal–Ga₂Se₃–nSi) considered here is shown in Fig. 1. With increasing intensity of light, the open circuit voltage, V_{oc} , of the cell increases, initially in accordance with the Shockley equation and then it starts to saturate. At a high level of illumination the concentration of the minority carrier becomes comparable with that of the majority carrier and as such a new expression for the majority carrier current, J_n , may be given as [8]

$$J_{\rm n} = J_{\rm no} \left\{ 1 + \frac{\delta p}{n_{\rm no}} \left[\exp(-q(V_{\rm s} - \Delta V_{\rm s})/kT) \right] \right\}$$
$$\times \exp(-b_{\rm n} \chi_{\rm n}^{1/2} \delta) \left[\exp(q\Delta V_{\rm s}/kT) - 1 \right] \quad (1)$$

and

$$(J_{\rm no})_{\rm effective} = J_{\rm no} \left\{ 1 + \frac{\delta p}{n_{\rm no}} \exp\left[-q(V_{\rm s} - \Delta V_{\rm s})/kT\right] \right\}$$
(2)

where δp is the number of excess carriers generated at high illumination; and ΔV_s is the change in V_s , where V_s is the drop across the base Si.

The majority current is increased by a factor

$$\left\{1 + \frac{\delta p}{n_{\rm no}} \exp\left[-q(V_{\rm s} - \Delta V_{\rm s})/kT\right]\right\}$$

This brings about a saturation in the voltage developed across the semiconductor which in turn saturates the change in the open circuit voltage.

The expression for the open circuit voltage is given by

$$V_{\rm oc} = \left(1 + \frac{\delta}{W} \frac{\varepsilon_{\rm s}}{\varepsilon_{\rm s'}}\right) \frac{kT}{q} \ln \left\{ \frac{J_{\rm sc}}{J_{\rm no}} \left[\exp(b_{\rm n} \chi_{\rm n}^{1/2} \delta) + 1\right] \right\} + \frac{\delta}{\varepsilon_{\rm s'}} q D_{\rm s} (f_{\rm s} - f_{\rm so})$$
(3)

where ε_s is the permittivity of compound semiconductor, Ga₂Se₃; W is the depletion width; b_n the tunnelling transmission coefficient; χ_n the barrier height for electrons (in electron volts); δ the thickness of the compound semiconductor layer (in nanometres); and D_s is the density of the surface states.

2. Results and discussion

The *I*–*V* characteristics of MS'S (with *n*Si, 1 Ω cm⁻¹ resistivity) solar cells at higher levels of illumination $C_r = 1, 2, ..., 6$) have been calculated for $D_s = 10^{13}$ m⁻² and $\delta = 3.4$ nm. The results are plotted in Fig. 2. Although the trend is the same as for the MOS solar cell [8], the open circuit voltage is greater for MS'S. From the *I*–*V* characteristics with a new value of J_{no} , V_{oc} has been plotted against log C_r , where C_r is the concentration ratio and varies from $C_r = 1, 10, 20, ..., 100, 200, ..., 1000$ (Fig. 3). On comparing the two types of solar cells (MOS and MS'S) at



Figure 1 Structure of the solar cell (Al-Ga₂Se₃-nSi).



Figure 2 Theoretical *I–V* characteristics at higher levels of illumination for MS'S (Al–Ga₂Se₃–*n*Si) with an intermediate layer thickness, $\delta = 3.4$ nm.

very high levels of illumination up to $C_r = 10^3$, it is seen that $V_{oc(sat)}$ for MS'S (0.793 V) is much higher than for MOS (0.643 V). Thus one gets higher open circuit voltage even at lower concentration ratios, C_r , with these MS'S solar cells.

3. Conclusions

Thus MS'S has proved to be a better alternative for photovoltaic applications because:

1. It has a thicker intermediate layer of $Ga_2Se_3 \approx 3.4$ nm, compared with only a 1.0 nm thick non-uniform layer in MOS solar cells that is only two-three lattice distances thick.

2. It has higher open circuit voltage, thereby improving the efficiency of the cell.



Figure 3 Variation of open circuit voltage, V_{oc} , with concentration ratio C_r , for MIS and MS'S structures.

3. It has a reduced number of interface states, i.e. $D_s = 10^{13} \text{ m}^{-2}$ for normal illumination, thus providing a better interface.

It is also seen that in the case of higher level illumination, the open circuit voltage is higher when compared with that of MIS.

References

- P. K. BHATNAGAR and M. BHATNAGAR, *Phys. Status Solidi A* 158 (1996) 9.
- B. I. SYSOEV, N. N. BEZRYADIN, Y. V. SYNOROV and B. L. AGAPOV, *ibid.* 94 (1986) 129.
- P. K. BHATNAGAR and M. BHATNAGAR, "LDSS" (Semiconductor Society of India, New Delhi, 1995).
- G. P. SRIVASTAVA, P. K. BHATNAGAR and S. R. DHARIWAL, Solid-State Elec. 22 (1979) 581.
- B. I. SYSOEV, N. N. BERZEYADIN, Y. V. SYNOROV, B. L. AGAPOV and T. A. KUZMENKO, *Inorganic Mater.* 27 (1991) N3.
- 6. B. I. SYSOEV, Private communication.
- M. BHATNAGAR and P. K. BHATNAGAR, in Proceedings of the Fourteenth European Photovoltaic Solar Energy Conference and Exhibition, Barcelona, 30 June–4 July 1997.
- P. K. BHATNAGAR, PhD thesis, University of Delhi, New Delhi (1979).

Received 23 September 1996 and accepted 5 December 1997